POWER AMPLIFICATION WITH GATE TURN-OFF CONTROLLED RECTIFIERS

RICHARD G. CAMACHO
POWER AMPLIFICATION WITH
GATE TURN-OFF CONTROLLED RECTIFIERS

* * * * *

Richard G. Camacho
POWER AMPLIFICATION WITH
GATE TURN-OFF CONTROLLED RECTIFIERS

by

Richard G. Camacho

Lieutenant, United States Navy

Submitted in partial fulfillment of
the requirements for the degree of

MASTER OF SCIENCE
IN
ELECTRICAL ENGINEERING

United States Naval Postgraduate School
Monterey, California

1964
POWER AMPLIFICATION WITH

GATE TURN-OFF CONTROLLED RECTIFIERS

by

Richard G. Camacho

This work is accepted as fulfilling

the thesis requirements for the degree of

MASTER OF SCIENCE

IN

ELECTRICAL ENGINEERING

from the

United States Naval Postgraduate School
ABSTRACT

With ever larger amounts of power being required by present day active sonars, studies are being made towards improving the efficiency of the power train. A gain in efficiency is possible if non-linear switching type amplifiers are used in lieu of the linear amplifiers presently used. Due to its high switching efficiency, fast switching, and ability to be turned on or off by gate signals, the Gate Turn-off Controlled Rectifier was investigated for possible application in an amplifier circuit.

The circuit examined readily met the required criteria, however, the real value of this study lies in the method of predicting transient performance. Use of the derived equivalent circuit, and an analog computer model based on transfer functions \( \frac{E_L}{E} \) and \( \frac{i_L}{E} \), provide analytical solutions that can be arrived at more readily than by other methods.
# TABLE OF CONTENTS

## CHAPTER I

The Gate Turn-off Controlled Rectifier

<table>
<thead>
<tr>
<th>Section</th>
<th>Description</th>
<th>Page</th>
</tr>
</thead>
<tbody>
<tr>
<td>I.1</td>
<td>Introduction</td>
<td>1</td>
</tr>
<tr>
<td>I.2</td>
<td>Turn-On Criterion</td>
<td>2</td>
</tr>
<tr>
<td>I.3</td>
<td>Gate Characteristics</td>
<td>7</td>
</tr>
</tbody>
</table>

## CHAPTER II

An Analysis of the Basic Power Amplifier

<table>
<thead>
<tr>
<th>Section</th>
<th>Description</th>
<th>Page</th>
</tr>
</thead>
<tbody>
<tr>
<td>II.1</td>
<td>Introduction</td>
<td>14</td>
</tr>
<tr>
<td>II.2</td>
<td>Operation of the Ideal Circuit</td>
<td>16</td>
</tr>
<tr>
<td>II.3</td>
<td>Analysis of the Experimental Circuit</td>
<td>21</td>
</tr>
<tr>
<td>II.4</td>
<td>Experimental Results for the Basic Power Amplifier</td>
<td>24</td>
</tr>
<tr>
<td>II.5</td>
<td>Discussion of Results</td>
<td>33</td>
</tr>
</tbody>
</table>

## CHAPTER III

The Power Amplifier with a Transducer Load

<table>
<thead>
<tr>
<th>Section</th>
<th>Description</th>
<th>Page</th>
</tr>
</thead>
<tbody>
<tr>
<td>III.1</td>
<td>Introduction</td>
<td>35</td>
</tr>
<tr>
<td>III.2</td>
<td>Analysis of Transducer Loading</td>
<td>38</td>
</tr>
<tr>
<td>III.3</td>
<td>Discussion of Analytical Results</td>
<td>44</td>
</tr>
<tr>
<td>III.4</td>
<td>Experimental Results</td>
<td>58</td>
</tr>
<tr>
<td>III.5</td>
<td>Conclusions Based on Experimental Results</td>
<td>68</td>
</tr>
</tbody>
</table>

## BIBLIOGRAPHY

<table>
<thead>
<tr>
<th>Page</th>
</tr>
</thead>
<tbody>
<tr>
<td>71</td>
</tr>
<tr>
<td>Figure</td>
</tr>
<tr>
<td>---------</td>
</tr>
<tr>
<td>I.1</td>
</tr>
<tr>
<td>I.2A</td>
</tr>
<tr>
<td>I.2B</td>
</tr>
<tr>
<td>I.3</td>
</tr>
<tr>
<td>I.4</td>
</tr>
<tr>
<td>I.5</td>
</tr>
<tr>
<td>I.6</td>
</tr>
<tr>
<td>I.7</td>
</tr>
<tr>
<td>II.1</td>
</tr>
<tr>
<td>II.2</td>
</tr>
<tr>
<td>II.3</td>
</tr>
<tr>
<td>II.4</td>
</tr>
<tr>
<td>II.5</td>
</tr>
<tr>
<td>II.6</td>
</tr>
<tr>
<td>II.7</td>
</tr>
<tr>
<td>II.8</td>
</tr>
<tr>
<td>II.9</td>
</tr>
<tr>
<td>II.10</td>
</tr>
<tr>
<td>II.11</td>
</tr>
<tr>
<td>III.1</td>
</tr>
<tr>
<td>III.2</td>
</tr>
<tr>
<td>III.3</td>
</tr>
<tr>
<td>III.4</td>
</tr>
</tbody>
</table>
List of Illustrations Cont'd

<table>
<thead>
<tr>
<th>Figure</th>
<th>Description</th>
<th>Page</th>
</tr>
</thead>
<tbody>
<tr>
<td>III.5</td>
<td>$i_1$ and $E_L$ for $C = 0.0021$</td>
<td>45</td>
</tr>
<tr>
<td>III.6</td>
<td>$i_1$ and $E_L$ for $C = 0.0042$</td>
<td>46</td>
</tr>
<tr>
<td>III.7</td>
<td>$i_1$ and $E_L$ for $C = 0.00612$</td>
<td>47</td>
</tr>
<tr>
<td>III.8</td>
<td>$i_1$ and $E_L$ for $C = 0.0082$</td>
<td>48</td>
</tr>
<tr>
<td>III.9</td>
<td>$i_1$ and $I_L$ for $C = 0.011$</td>
<td>49</td>
</tr>
<tr>
<td>III.10</td>
<td>$i_1$ and $E_L$ for $C = 0.016$</td>
<td>50</td>
</tr>
<tr>
<td>III.11</td>
<td>$i_1$ and $E_L$ for $C = 0.0212$</td>
<td>51</td>
</tr>
<tr>
<td>III.12</td>
<td>$i_1$ and $E_L$ for $L = 9/8 L_1$</td>
<td>53</td>
</tr>
<tr>
<td>III.13</td>
<td>$i_1$ and $E_L$ for $L = 5/4 L_1$</td>
<td>54</td>
</tr>
<tr>
<td>III.14</td>
<td>$i_1$ and $E_L$ for $L = 3/2 L_1$</td>
<td>55</td>
</tr>
<tr>
<td>III.15</td>
<td>$i_1$ and $E_L$ for $L = 2 L_1$</td>
<td>56</td>
</tr>
<tr>
<td>III.16</td>
<td>$i_1$ and $E_L$ for $L = 6 L_1$</td>
<td>57</td>
</tr>
<tr>
<td>III.17</td>
<td>$M_{pt}$ vs $\bar{F}$</td>
<td>59</td>
</tr>
<tr>
<td>III.18</td>
<td>$w_{tp}$ vs $\bar{F}$</td>
<td>60</td>
</tr>
<tr>
<td>III.19</td>
<td>$E_L$ observed, $C = 0.0021$</td>
<td>61</td>
</tr>
<tr>
<td>III.20</td>
<td>$E_L$ observed, $C = 0.0042$</td>
<td>62</td>
</tr>
<tr>
<td>III.21</td>
<td>$E_L$ observed, $C = 0.00612$</td>
<td>63</td>
</tr>
<tr>
<td>III.22</td>
<td>$E_L$ observed, $C = 0.0082$</td>
<td>64</td>
</tr>
<tr>
<td>III.23</td>
<td>$E_L$ observed, $C = 0.011$</td>
<td>65</td>
</tr>
<tr>
<td>III.24</td>
<td>$E_L$ observed, $C = 0.016$</td>
<td>66</td>
</tr>
<tr>
<td>III.25</td>
<td>$E_L$ observed, $C = 0.021$</td>
<td>67</td>
</tr>
<tr>
<td>A-1</td>
<td>Four Layer Diode Characteristics</td>
<td>73</td>
</tr>
<tr>
<td>A-2</td>
<td>Analog Circuit for $i_1$</td>
<td>76</td>
</tr>
<tr>
<td>A-3</td>
<td>Analog Circuit for $E_L$</td>
<td>81</td>
</tr>
</tbody>
</table>
CHAPTER ONE

THE GATE TURN-OFF CONTROLLED RECTIFIER

1.1 Introduction.

The Gate Turn-off Controlled Rectifier, GTCR, is a three terminal, p-n-p-n silicon structure very similar to the Silicon Controlled Rectifier, SCR. It differs from the SCR in that conduction through the device can be stopped by the application of negative pulses to the gate terminal.

The GTCR enjoys the following advantages which the SCR has over other switching devices:[1]

a. A high switching efficiency.
b. High surge current ratings.
c. Large power gain.
d. Pulse turn on.
e. Extremely fast switching times.

The SCR's were found to be limited in switching capabilities, since the turn-off required either a drop in current below the rated holding current, or the application of a voltage of opposite polarity across the device, so that the operating point is moved into the blocking state.

The typical operating characteristic of both devices is shown in Figure I-1. Note that by applying the gate current, the Forward Breakover Voltage is moved to the left.
Fig. I-1
1.2 Turn-On Criterion.

In examining the turn-on criterion of the p-n-p-n device we will employ the widely used two transistor analog. [3] Figures I-2A and I-2B show how we can pictorially represent our analog.

Figure I-2A Schematic of GTGR

\[ \begin{array}{c}
\text{Anode} \\
I_A \\
\end{array} \]

\[ \begin{array}{c}
P \\
J_1 \\
\alpha_N I_A \\
\alpha_P I_K \\
n \\
I_{op} \\
\ldots \\
I_{on} \\
p \\
J_2 \\
n \\
J_3 \\
I_K \\
\text{Cathode} \\
\end{array} \]

\[ \begin{array}{c}
\text{Gate} \\
I_g \\
\end{array} \]

where \( J_1, J_2 \) and \( J_3 \) are the junctions

\[ \begin{array}{c}
\ldots \text{represents electron current} \\
\ldots \text{represents hole current} \\
\end{array} \]

Fig. I-2B 2 Transistor Analog

\[ \begin{array}{c}
\text{emitter} \\
P \\
I_A \\
\end{array} \]

\[ \begin{array}{c}
\text{base} \\
n \\
\alpha_N \\
\end{array} \]

\[ \begin{array}{c}
\text{collector} \\
P \\
T_1 \\
\end{array} \]

\[ \begin{array}{c}
\text{gate} \\
I_g \\
\end{array} \]

\[ \begin{array}{c}
\text{collector} \\
n \\
\alpha_P \\
\end{array} \]

\[ \begin{array}{c}
\text{base} \\
P \\
T_2 \\
\end{array} \]

\[ \begin{array}{c}
\text{emitter} \\
n \\
I_K \\
\end{array} \]
We can define the DC alphas in the usual manner as the ratio of collector current resulting from the emitter current, to the emitter current. Thus in general the total current collected will be:

\[ I_c = \alpha I_e + I_{co} \]

where \( I_{co} \) is the amount of thermally generated current collected.

The small signal \( \alpha 's \) can then be defined as:

\[ \alpha_o = \frac{dI_c}{dI_e} = \alpha + I_e \frac{d\alpha}{dI_e} \]

From Figure I-2A we see that if \( I_k = I_a + I_g \) the current through Junction 2 must be \( I_a \) which is the sum of the hole, electron, thermal, and displacement current, \( I_{dis} = \frac{CdV}{dt} \), where \( C \) = the capacitance of \( J_2 \)

\[ I_a = \alpha_n I_a + \alpha_p I_k + I_{co} + I_{dis} \]  

since

\[ I_k = I_a + I_g \]

\[ I_a = \frac{\alpha_p I_g + I_{co} + I_{dis}}{1 - \alpha_n - \alpha_p} \]

Before discussing the results of this expression let us examine Figure I-3 which shows the general relationship between emitter current \( I_e \) and the small signal \( \alpha 's \).

![Graph showing the relationship between \( \alpha \) and \( I_e \)](image-url)
We can see that the small signal $\alpha$'s increase monotonically with emitter current. We desire now an expression for $\frac{\Delta I_a}{\Delta I_g}$ to see what the small signal requirements are for $\frac{\Delta I_a}{\Delta I_g} \rightarrow \infty$ which is the criteria for switching on.

$\frac{\Delta I_a}{\Delta I_g} \rightarrow \infty$ implies that $I_g$ may $\rightarrow \infty$ without affecting $I_a$. To get the desired relationship, differentiate (1) with respect to $I_g$.

\[
\frac{d}{dI_g} \frac{\Delta I_a}{\Delta I_g} = \alpha_n \frac{d}{dI_g} \frac{\Delta I_a}{\Delta I_g} + I_a \frac{d}{dI_g} \alpha_n + \alpha_p \frac{d}{dI_g} \frac{\Delta I_k}{\Delta I_g} + I_k \frac{d}{dI_g} \alpha_p
\]

but as previously shown

\[
\frac{d\alpha_n}{dI_a} = \frac{\alpha_n}{I_a} - \frac{\alpha_n}{I_a}
\]

\[
\frac{d\alpha_p}{dI_k} = \frac{\alpha_p}{I_k} - \frac{\alpha_p}{I_k}
\]

Where $\alpha_n$ and $\alpha_p$ are the small signal alphas.

We can furthermore simplify to get:

\[
\frac{d\alpha_n}{dI_g} = \frac{d\alpha_n}{dI_a} \cdot \frac{dI_a}{dI_g} = \frac{\alpha_n}{I_a} \frac{dI_a}{dI_g} - \frac{\alpha_n}{I_a} \frac{dI_a}{dI_g}
\]

and

\[
\frac{d\alpha_p}{dI_g} = \frac{\alpha_p}{I_k} \frac{dI_k}{dI_g} - \frac{\alpha_p}{I_k} \frac{dI_k}{dI_g}
\]

Now substitute these results into (3),

\[
\frac{dI_a}{dI_g} = \frac{\alpha_n}{I_a} \frac{dI_a}{dI_g} + \frac{\alpha_p}{I_k} \frac{dI_k}{dI_g} - \frac{\alpha_n}{I_a} \frac{dI_a}{dI_g} + \frac{\alpha_p}{I_k} \frac{dI_k}{dI_g} + \frac{I_k \alpha_p}{I_k} \frac{dI_k}{dI_g} - \frac{I_k \alpha_p}{I_k} \frac{dI_k}{dI_g}
\]

which reduces as follows:

\[
\frac{dI_a}{dI_g} = \alpha_n \frac{dI_a}{dI_g} + \alpha_p \frac{dI_k}{dI_g}
\]

since

\[
I_k = I_a + I_g, \quad \frac{dI_k}{dI_g} = \frac{dI_a}{dI_g} + 1
\]

hence, \[
\frac{dI_a}{dI_g} = \frac{\alpha_n}{1 - \alpha_p - \alpha_n}
\]
We are now in a position to form some conclusion regarding switching. For \( \alpha_{no} + \alpha_{po} = 1 \) we note that \( \frac{dI_a}{dI_g} \rightarrow \infty \).

This then is our turn-on requirement, which as we see from Figure I-3 is brought about by \( \alpha_{po} \) and \( \alpha_{no} \) increasing steadily as their respective emitter currents increase.

Similarly we note that at turn-off, when current is pulled out of the gate, \( \alpha_P \) decreases first, then \( \alpha_N \) decreases and from equation (2) we see that \( I_a = I_{co} + I_{dis} - \alpha_P I_g \) which is the very small leakage current.

In the conducting state all three junctions are forward biased and saturated with carriers. Unlike the SCR which requires an additional incremental time to allow for the diffusion of the carriers from the center junction after turnoff, the GTCR is completely turned off when the carriers are removed due to the negative gate pulse. Hence the GTCR is capable of much higher frequency operations.

It becomes apparent then that the function of the amplitude of the gate current is to control the variables \( \alpha_N \) and \( \alpha_P \). If \( I_{co} \) and \( I_{dis} \) are negligible then \( \frac{I_a}{I_g} \approx \frac{\alpha_P}{1 - \alpha_P - \alpha_N} \).

As previously discussed for turn-on, we desire to have the gate current such that the emitter currents will cause \( \alpha_N + \alpha_P = 1 \). Further, for high turn-off gains we would desire \((\alpha_P + \alpha_N) \rightarrow 1, \alpha_P > \alpha_N\). At present turn-off gains on the order of 10-20 are possible.
I.3 Gate Characteristics.

There are two means of turning on the GTCR, by exceeding the forward breakover voltage, and by gate currents. Since switching by gate current is the more practical means, we will examine only this method.

The Gate Turn-on and Turn-off characteristics for the Westinghouse WX 241W GTCR are shown in Figures I-4, 5, 6 and 7. These characteristics are considerably affected by:

(a) the gate pulse
   1. magnitude
   2. width

(b) the load

(c) the temperature of the junctions

In addition the turn-off characteristics are affected by the anode current to be turned off.

In Figure I-4 we see the switching locus with $I_a$ and gate voltage $V_g$, and gate current $I_g$, the variables. These curves were constructed for $R_l = 50$ ohms and $T_j = 125^\circ$C. If we start at $I_a = I_g = V_g = 0$ and move along the $I_a = 0$ curve in the direction of increasing $I_g$ and $V_g$, we arrive at the turn-on point at which the curve becomes discontinuous and shifts to the curve of the applicable anode current.

Similarly, if we desire to turn the device off we can follow the curve for the operating anode current down to the point marked turn-off, at which we read the required turn-off gate voltage and current. We can readily observe the effects on turn-off requirements for different anode currents from this figure.

In Figure I-5 are plotted the maximum gate power curves showing the rated DC and peak gate power. To gate the device, we must operate below these curves, and above the shaded areas which represent the turn-on and
The advantage of pulse gate drive is that higher currents and terminal voltages may be used without exceeding the power rating of the device. This can be shown by considering the switching efficiency:

\[
\text{Power out} \quad \text{if, } A_p = \frac{\text{Power in}}{\text{Power out}} = \text{the power gain}
\]

and

\[
\eta_{\text{switching}} = \frac{\text{Power out}}{\text{Power out} + \text{losses}} = \text{efficiency}
\]

and since the power input to the gate does not contribute power to the load, but is all lost

\[
\text{power input} = \text{losses} = \frac{P_{\text{out}}}{A_p}
\]

the efficiency is then

\[
\eta_{\text{switching}} = \frac{P_{\text{out}}}{P_{\text{out}}(1 + 1/A_p)} = \frac{1}{1 + \frac{1}{A_p}}
\]

For bistable switching as we have with the GTCR, the time base of the input differs from that of the output, thus the gain \(A_p\) must be corrected by the factor \(\frac{T_1}{t}\) where:

\[
T_1 = \text{the conduction interval}
\]

and \(t\) = the gate interval (pulse width)

thus,

\[
\eta_{GTCR} = \frac{1}{1 + \frac{1}{A_p (\frac{T_1}{t})}}
\]

thus for a \(T_1 = 0.50\) millisecond and a gate pulse width of \(10 \mu\text{sec}\) we have increased the effective gain by a factor of 500 and reduced the amount of power to be dissipated in the device.

The variation of the turn-off gains with anode currents for two values of junction temperature are shown in Figure I-6. On examining these curves, we note that the gains decrease with increasing temperature, which can be attributed mainly to the increase in the thermal
currents.

From Figure 1-7, we can get an idea about the order of the switching time and power controlled. For the circuit shown in the Figure we observe that 1000 watts can be switched in 5 micro seconds with a source voltage of 500 volts, anode current of 2 amperes, and junction temperature of 80°C.
Typical Gate Characteristics of the WX241W Turn-Off TRISTOR Controlled Rectifier

Fig. I-4
Gate Characteristics of the WX241W

Turn-Off TRINISTOR Controlled Rectifier

Fig. I-5
Typical Turn-Off Current Gain for the WX241W
Turn-Off TRINISTOR Controlled Rectifier

Fig. I-6
Typical Pulse Gate Drive Turn-Off Characteristics of the WX241W Turn-Off TRINISTOR Controlled Rectifier
CHAPTER TWO

AN ANALYSIS OF THE BASIC POWER AMPLIFIER

II.1 Introduction.

Due to its high switching efficiency, and fast switching ability it was felt that the gate turn-off controlled rectifier, GTCR, might be utilized in an amplifier circuit where the preservation of wave shape was unimportant, and the emphasis was on power amplification, efficiency and frequency correspondence. Accordingly, a basic inverter circuit employing two (2) GTCR's and a center tapped transformer as shown in Figure II-1 was investigated.

In part I of the Analysis, the amplifier was used with a simple resistive load and basic loop equations were written to solve for amplifier and load current, output voltage, power gain and efficiency. From these solutions an equivalent circuit was established to investigate loads considered in II-2 and III-1.

In each experimental circuit the input or triggering pulse was obtained from the circuit shown in Appendix I and was of 1.5 amps, peak amplitude, and approximately 10 μsec duration.
II.2 Operation of the Ideal Circuit.

Consider the circuit shown below:

Fig. II-1 Operation of the Ideal Circuit
Assumptions: 1. Trigger pulse has no effect on load.
   3. \( n = \text{primary turns per loop} \), \( n' = \text{secondary turns} \)
      \[ N = \frac{n}{n'} \], iron core transformer, \( k \approx 1 \)
   4. Voltage drop, \( V_o \), across the conducting GICR, \( \approx 1 \) volt
   5. # 1 conducting, # 2 open

Loop equations

(1) \[ E = V_0 + L_1 \frac{di_1}{dt} - M \frac{di_2}{dt} - M' \frac{di_4}{dt} \]

(2) \[ E = i_2 R_e + L_2 \frac{di_2}{dt} - M \frac{di_1}{dt} + M' \frac{di_4}{dt} + \frac{1}{c} \int i_2 dt \]

(3) \[ 0 = -M' \frac{di_1}{dt} + M' \frac{di_2}{dt} + L_1 \frac{di_4}{dt} + i_2 R_e \]

where:

\( L_1 = \text{self inductance of loop 1} \)
\( L_2 = \text{self inductance of loop 2} \)
\( L_L = \text{self inductance of secondary loop} \)
\( R_1 = \text{the load resistance} \)

(4) with \( k \approx 1 \), and \( M = L_1 = L_2 \)
\[ M' = \sqrt{L_1 L_L} = \sqrt{M L_L} \]
\[ L_L = \frac{n' \phi}{\lambda_1} = \frac{n' \phi}{n} \times \frac{n \phi}{n} = \frac{n'^2}{n^2} \times \frac{n \phi}{\lambda_1} \]
but \( \frac{n'^2}{n^2} = \frac{1}{N^2} \) and \( \frac{n \phi}{\lambda_1} = L_i, \approx M \)
therefore \( L_L \approx \frac{L_1}{N^2} \approx \frac{M}{N^2} \approx \frac{L_2}{N^2} \) and \( M' \approx \frac{M}{N} \)
(5) adding (1) + (2) and using \( L_1 = M = L_2 \)

\[
2E - V_0 = \frac{1}{R_c} \int i_z \, dt + \frac{1}{c} \int i_z \, dt
\]

expressing \( i_z \) in LaPlace transform: we get (6)

\[
\frac{2E - V_0}{s} = I_z(s)R_c + \frac{1}{cS} \int I_z(s) \, dt
\]

\[
I_z(s) = \frac{2E - V_0}{R_c \left(s + \frac{1}{R_cC}\right)}
\]

(7) \( i_z(t) = \frac{2E - V_0}{R_c} e^{-\frac{t}{R_cC}} \)

now multiply (3) by \( N \) and add to 1

(1) \( E = V_0 + L_1 \frac{di_1}{dt} - M \frac{di_2}{dt} - M^{'} \frac{di_3}{dt} \)

\[
N \times (3) = 0 = -M^{'} N \frac{di_1}{dt} + M^{'} N \frac{di_2}{dt} + N L \frac{di_2}{dt} + N L R L
\]

but, \( M^{'} N = L_1 = L_2 \) and \( N L L \approx M^{'} \)

(8) hence (1) + \( N \times (3) \)

\[
E - V_0 = N i_L R_L \quad \text{or} \quad i_L = \frac{E - V_0}{N R L}
\]

(9) or assuming \( i_\text{magnetizing} = 0 \), \( i_L \approx N (i_1 - i_2) \)

and

\[
i_1 = \frac{(E - V_0)}{N^2 R_L} + \frac{(2E - V_0)}{R_c} e^{-\frac{t}{R_cC}}
\]

17
\[ \dot{i}_{dc} = \dot{i}_1 + \dot{i}_2 = \left( \frac{E - V_o}{N^2 R_L} \right) + \left( \frac{4E - 2V_o}{R_c} \right) e^{-\frac{t}{R_c C}} \]

\[ E_L = i_L R_L = \frac{E - V_o}{N} \]

(10) From (7) it is apparent that the maximum voltage across either GTCR is \(2E - V_o\).

(11) The power input to the circuit is

\[ \text{Power in} = I_{dc} E \]

where

\[ I_{dc} \text{=} \dot{i}_{dc} \text{average} \]

\[ \dot{i}_{dc} = \frac{E - V_o}{N^2 R_L} + \left( \frac{4E - 2V_o}{R_c} \right) \int_0^T e^{-\frac{t}{R_c C}} dt \]

(12) For \( T \gg R_c C \)

\[ I_{dc} = \frac{E - V_o}{N^2 R_L} + \left( \frac{4E - 2V_o}{T} \right) C \]

(13) Power output

\[ P_o = I_L^2 R_L = \frac{E_L^2}{R_L} = \frac{(E - V_o)^2}{N^2 R_L} \]

(14) Efficiency

\[ \eta = \frac{P_{out}}{P_{in}} = \frac{(E - V_o)^2}{\frac{E - V_o}{N^2 R_L} + \left( \frac{4E - 2V_o}{T} \right) C} \]

(15) Power gain = \frac{\text{Power Output}}{\text{Power required from trigger}}

(16) For \( \frac{E - V_o}{N^2 R_L} \gg \left( \frac{4E - 2V_o}{T} \right) C \)

\[ I_{dc} \approx \frac{E - V_o}{N^2 R_L} \]

and maximum

\[ \eta = 1 - \frac{V_o}{E} \]

If \( E = 30 \text{ volts} \) and \( V_o = 1 \text{ volt} \), \( \eta_{\text{max}} = 0.967 \)
Taking the current equations

\[ i_1 = \frac{E - V_0}{N^2 R_L} + \frac{(2E - V_0)}{R_c} e^{\frac{-t}{R_c C}} \]

and

\[ i_2 = \frac{(2E - V_0)}{R_c} e^{\frac{-t}{R_c C}} \]

\[ i_{dc} = i_1 + i_2 = \frac{E - V_0}{N^2 R_L} + \frac{(4E - 2V_0)}{R_c} e^{\frac{-t}{R_c C}} \]

Since \( E \gg V_0 \), neglect \( V_0 \), then

\[ i_{dc} = \frac{E}{N^2 R_L} + \frac{E}{4R_c} e^{\frac{-t}{R_c C}} \]
The equivalent circuit for these equations is shown below:

Fig. II-2
II-3 Analysis of the Experimental Circuit.

If we examine Figure II-4, which is the experimental setup for the basic amplifier circuit, we note that to correctly obtain a good comparison between calculated and observed results we must include in the calculated results the effect of the balancing resistors \( R_1 \) and \( R_2 \) and the inductance, \( L_L \), associated with the load resistor \( R_1 \). We can introduce these parameters into our equivalent circuit as shown in Figure II-3.

![Circuit Diagram](image)
We can use the LaPlace Transform directly, for step inputs: $E'(s) = \frac{E}{s}$
and since $R_1 \approx R_2$

$$I_c(s) = I_2(s) = \frac{E}{s} \frac{1}{R_1 + \frac{R_c}{2}} + \frac{1}{2Cc s}$$

and the load component reflected into the primary will be,

$$I_L'(s) = -\frac{E}{N^2 L_L} s \left( \frac{1}{s + \frac{R_1 + N^2 R_L}{N^2 L_L}} \right)$$

the time domain solutions for current can then be shown as:

$$i_c(t) = i_2(t) = \frac{E}{R_1 + \frac{R_c}{2}} e^{-\frac{t}{\tau_1}}$$

$$\tau_1 = 2Cc (R_1 + \frac{R_c}{2})$$

and the load current in the primary

$$i_L'(t) = \frac{E}{R_1 + N^2 R_L} \left( 1 - e^{-\frac{t}{\tau_2}} \right), \quad \tau_2 = \frac{N^2 L_L}{R_1 + N^2 R_L}$$

The current thru the conducting GTCR is the sum of $i_L' + i_c$

or

$$i_L(t) = \frac{E}{R_1 + N^2 R_L} \left( 1 - e^{-\frac{t}{\tau_2}} \right) + \frac{E}{R_1 + \frac{R_c}{2}} e^{-\frac{t}{\tau_1}}$$

We can get the load current by reference to the secondary

where

$$I_L(s) = I_L'(s) N$$

Since the output voltage

$$E_L(s) = I_L(s) \left( R_L + s L_L \right)$$

$$E_L(s) = \frac{E}{N L_L} \frac{R_1 + s L_L}{s \left( s + \frac{R_1 + N^2 R_L}{N^2 L_L} \right)}$$
this can be simplified to

\[ E_L(s) = \frac{ER_LN}{R_i + N^2R_L} \frac{1}{s} - \frac{ER_LN}{R_i + N^2R_L \left( s + R_i + N^2R_L \right)} + \frac{E}{N} \frac{1}{N \left( s + R_i + N^2R_L \right)} \]

We can now write the time response as the inverse transform

\[ E_L(t) = \frac{ER_LN}{R_i + N^2R_L} \left( 1 - e^{-\left( \frac{R_i + N^2R_L}{N^2L} \right) t} \right) + \frac{E}{N} \left( \frac{R_i + N^2R_L}{N^2L} \right) t \]
II-4 Experimental Results for the Basic Power Amplifier.

The laboratory setup for the circuit shown in Figure II-1 is shown below:

![Circuit Diagram]

**Parameters:**

- \( E_L = 30 \) volts
- \( V_0 = 1 \) volt
- \( N = \frac{1}{6} \)
- \( N^2 = \frac{1}{36} \)
- \( R_c = 30 \) ohms
- \( C_c = 0.15 \) \( \mu \) farads
- \( N^2L_L = 2 \) mh
- \( R_1 \approx R_2 = 5 \) ohms
- \( R_L = 1200 \) ohms
It was found in the laboratory that without the resistors $R_1$ and $R_2$ shown in Figure II-4, the basic circuit would not operate. Analysis of the problem indicated that the transformer was saturating on the first half cycle, because a residual flux raised the level into the saturated region. Hence these resistors were needed to start the operation of the amplifier, and then to properly balance the output during each half cycle, which prevented a buildup of the flux level in either direction. If we could obtain perfectly matched components, at considerably more expense, it would be possible to shunt out these resistors completely after start up.

For the parameters given, the equations for predicted currents become:

\[ i_2 = i_c = \frac{30}{5+15} e^{-\frac{t}{6 \times 10^{-6}}} = 1.5 e^{-\frac{10^6 t}{6}} \text{ amperes} \]

the primary component of load current

\[ i_3' = \frac{30}{5+1200} (1 - e^{-\frac{386 t}{2 \times 10^{-3}}}) = .783 (1 - e^{-\frac{10^6 t}{51.8}}) \text{ amps} \]

the current through the conducting GTCR

\[ i_1 = i_3' + i_c = .783 (1 - e^{-\frac{10^6 t}{51.8}}) + 1.50 e^{-\frac{10^6 t}{6}} \text{ amps} \]

the current from the source,

\[ i_{dc} = i_1 + i_2 \]

\[ i_{dc} = .783 (1 - e^{-\frac{10^6 t}{51.8}}) + 3.0 e^{-\frac{10^6 t}{6}} \text{ amps} \]
the average value of source current

\[ I_{dc} = I_{dc\text{ave}} = 0.783 - 0.783 \int_0^T e^{-10^6 t} \frac{1}{51.8} dt + 3.0 \int_0^T e^{-10^6 t} \frac{1}{6} dt \]

for \( T = 0.0005 \) seconds

\[ I_{dc} = 0.783 - 0.078 + 0.035 = 0.74 \text{ amperes} \]

Our calculated output voltage, \( E_L \), becomes

\[ E_L = \frac{(30)(1200)(1)}{5 + \frac{1200}{36}} (1 - e^{-10^6 t}) + 180 e^{-10^6 t} \]

which reduces to

\[ E_L = 155.5 (1 - e^{-10^6 t}) + 180 e^{-10^6 t} \text{ volts} \]

Power input = \( 0.74 \times 30 = 22.20 \) watts

Average current

\[ I_{ave} = N I_{ave} = \frac{1}{6} (0.783 - 0.078) = 0.1175 \text{ amps} \]

Output Power

\[ P_{out} = (0.1175)^2 \times 1200 = 16.57 \text{ watts} \]

efficiency, \( \eta_{cal} = \frac{16.57}{22.2} = 0.746 \)

In an attempt to obtain a better comparison of the predicted versus experimental results, the equations for the current, \( i_1 \), and the output voltage, \( E_1 \) can be solved by an analog computer. The analog circuits used are shown in Figures II-5 and II-6. The graphic solutions as shown in Figures II-7 and II-8 may be visually compared with the pictures taken.
Table I presents for comparison the observed and calculated results. The calculations were based on the parameters listed and the equations derived above.

<table>
<thead>
<tr>
<th>Variable</th>
<th>Calculated</th>
<th>Observed</th>
</tr>
</thead>
<tbody>
<tr>
<td>$i_1$</td>
<td>-10^6 t/51.8 -10^6 t/6 [0.785(1-e^{-t/T_1})+1.5e] [0.8(1-e^{-t/T_1})+1.52e] amps</td>
<td></td>
</tr>
<tr>
<td>$i_2$</td>
<td>-10^6 t/6 [1.50e] [-t/T_2] amps</td>
<td></td>
</tr>
<tr>
<td>Idc</td>
<td>[0.74] [0.75] amps</td>
<td></td>
</tr>
<tr>
<td>$E_L$</td>
<td>-10^6 t/51.8 -10^6 t/51.8 [155.5(1-e^{-t/T_1})+180e] [153(1-e^{-t/T_1})+180e] volts</td>
<td></td>
</tr>
<tr>
<td>Power input</td>
<td>22.20</td>
<td>22.50 watts</td>
</tr>
<tr>
<td>Power output</td>
<td>16.57</td>
<td>17.5 watts</td>
</tr>
<tr>
<td>Efficiency</td>
<td>0.746</td>
<td>0.778</td>
</tr>
<tr>
<td>Power Gain</td>
<td>828</td>
<td>875</td>
</tr>
</tbody>
</table>
of the observed variables shown in Figures II-9 and II-10.

For ease in the analog solution the equation for the current can be expressed by:

\[ I(s) = \frac{E}{(R_1 + N^2R_L)} \left( \frac{1}{s(N^2L + \frac{R_L}{R_1 + N^2R_L} + 1)} \right) + \frac{E}{s(R_1 + R_c)} - \frac{E}{s(2C_c(R_1 + R_c) + 1)} \]

Fig. II-5
tor parameters used: \( \alpha_E = 2 \), \( \alpha_i = 0.05 \), \( \alpha_t = 10^5 \)

and scaling factors

\[
\begin{align*}
\alpha_1 &= 0.15 \quad R_1 = R_{f1} = 1 \text{ Megohm} \\
\alpha_2 &= 0.199 \quad a_3 = 0.192 \quad R_2 = R_3 = 1 \text{ Megohm} \\
\alpha_4 &= 0.5 \quad \alpha_5 = 0.167 \quad C_{\varphi 2} = 1 \text{ microfarad} \\
\alpha_6 &= \alpha_7 = 0.5 \quad R_6 = R_7 = 0.25 \text{ Megohm}, R_{f6} = 1 \text{ Megohm} \\
\alpha_8 &= \alpha_9 = 1 \quad R_8 = R_9 = R_{f8} = 1 \text{ Megohm}
\end{align*}
\]

Similarly the output voltage equation can be expressed as:

\[
E_{L}(s) = \frac{E_{N}R_{L}}{(R_1 + N^2R_L) s(N^2L_s + 1)} + \frac{E}{NS} - \frac{E}{N s(N^2L_s + 1)}
\]

which can be solved as shown in Figure II-6.
Analog Solution for Predicted Response of Amplifier

Scale:
vertical: 1 volt/line
horizontal: 1 mm/second

Scaling factors:
\[ \alpha_{time} = 10^5 \text{ sec} \quad \alpha_{i} = 0.05 \text{amps/volt} \quad \alpha_{v} = 6 \text{volts/volt} \]
For the parameters given, let

\[ \alpha_E = 6 \quad \alpha_t = 10^5 \]

and let

\[ a_1 = 0.3 \quad R_1 = R_{f1} = 1 \text{ Meg-ohm} \]
\[ a_2 = 0.5 \quad R_2 = R_{f2} = 1 \text{ Mic-ohm} \]
\[ a_3 = 0.575 \quad C_{f2} = 1 \text{ microfarad} \]
\[ a_4 = 0.575 \quad R_4 = R_{f4} = 1 \text{ Meg-ohm} \]
\[ a_5 = 0.575 \quad C_{f4} = 1 \text{ microfarad} \]
\[ a_6 = 1 \quad R_6 = R_7 = R_{f6} = 1 \text{ Meg-ohm} \]
\[ a_7 = 1 \]
\[ a_8 = 1 \quad R_8 = R_9 = R_{f8} = 1 \text{ Meg-ohm} \]
\[ a_9 = 1 \]
Fig. II-9

Amplifier Current vs Time

Fig. II-10

Output Voltage $E_L$ vs Time
Fig. II-11

GTGR Voltage

1 cm = 20 volts

Voltage across GTGR vs Time

1 cm = 200 μsec
II-5 Discussion of Results.

In Section II-2 the basic assumptions which resulted in simplified solutions for $i_1$ and $E_L$ were that the co-efficient of coupling $k$, was essentially unity and that the magnetizing current was negligible. The resulting equations then predicted the various wave shapes and values of the variables of interest, namely $i_1$, and $E_L$, in terms of the applied voltage $E$. Thus the voltage $E$ could be selected to remain within the rated voltage of the GTCRs. The predicted maximum efficiency was 96.7% which is quite high, but if line and transformer losses are kept low it is felt that for a resistive load the efficiency will be greater than 90%.

An important result of Section II-2 was the development of an equivalent circuit which greatly simplified the solutions for Sections II-3 and later work in Chapter Three where the load became more complex.

To examine the validity of the assumptions made in Part I, an experimental circuit was established as developed in Part II. This was the simplest form of the power amplifier which could be constructed with the material on hand. To more correctly compare the analytically predicted results with the observed results, another analysis was performed which included the inductance inherent in the wire-wound power resistor used, and also the effects of the trimming resistances in each leg of the primary.

From the tabulated results we note that the calculated magnitudes agree very closely with the observed results, differing by less than 2% in each case. This deviation being well within the accuracy of the observed measurements which were obtained from an oscilloscope. In
conclusion then, it appears that the basic assumptions are valid and that the equivalent circuit is useful for varying loads. Since the solutions for amplifier current $i_1$, and output voltage $E_L$ satisfy the observed amplitudes and wave shape they can be examined more closely to see what effect the varying of the parameter $L_L$ will have on circuit operations. It can readily be shown that increasing $L_L$ has little effect on $E_L$ other than flattening the overshoot, however, when $L_L$ is increased, the current $i_1$ will exhibit more undershoot, as indicated by equation (21). This is undesirable since if the undershoot drops below the rated holding current, and pulse gate drive is being used, the device will switch to the off position and the amplifier operations will be terminated. Thus for a fixed resistance there exists an upper limit of inductance which can be tolerated if the circuit is to function.
III.1 Introduction.

Now that we have developed an equivalent circuit and shown that it will predict results which agree with observed results let us examine analytically and experimentally, amplifier performance when the complex load becomes a transducer.

Figure III-1 shows the equivalent load seen by the amplifier, where \( R_L \) and \( C \) are the transducer equivalent and \( L_L \) is a tuning coil in series with the load.

In electrical terms a basic loading problem inherent with the transducer, is a coupling effect which causes the capacitance, \( C_c \), in the equivalent circuit to vary. Thus the amplifier in meeting the operational requirements below, must do so for a range of possible capacitance, \( C \).

1. While the output voltage wave shape may be distorted, the amplifier must maintain frequency correspondence with the input signal.

2. The amplitude of the output voltage should remain nearly constant through the range of \( C \) employed.

3. High power gains at efficiencies on the order of 60\% or greater are demanded.

There are several general forms of equivalent circuits for transducers which depend primarily on transducer construction and the frequencies to be employed. For our study let us consider a circuit whose general form is shown in Figure III-1.
Since impedances are easily scaled in both magnitude and frequency so that laboratory models can be built to simulate existing circuits, the load simulated in the laboratory and used for our analytical results was based on values of $R_L$, $L_L$ and $C$ available. The objective then was to show the transient behavior when first $L_L$ and $R_L$ are kept constant while $C$ varies, then keeping $R_L$ and $C$ constant the tuning coil was varied to note the damping effects, if any, introduced in the circuit.

It is important that we have some indices which reflect the relative bearing of the three parameters in order to investigate possible transient behavior. If we examine Figure III-1 we note that,

\[ Z_L(s) = sL_L + \frac{R_L}{R_LCs + 1} \]

which simplified is:

\[ Z_L(s) = \frac{1}{R_LL_LLC} \left( \frac{s^2 + \left( \frac{1}{R_LC} \right)s + \frac{1}{L_LC}}{R_LCS + 1} \right) \]
The numerator of this expression will occur in both the current and output voltage equations, and will in fact become the characteristic equation which will govern the response. Hence, this equation, of second order form, may in general be written:

\[ s^2 + 2 \xi \omega_n s + \omega_n^2 \]

where \( \xi = \frac{1}{2R_L} \sqrt{\frac{L}{C}} \) and \( \omega_n = \sqrt{\frac{1}{LRC}} \).

Thus the parameters can be changed into \( \xi \) and \( \omega_n \) indices for comparison with other possible parametric values. Additionally, since considerable analytical information has been gathered and evaluated on the transient response to step inputs for second order systems we can easily obtain information such as overshoot and rise time for given values of \( \xi \) and \( \omega_n \). Figures III-17 and III-18 for example can be used in the analytical calculations to predict rise times, \( t_p \), and overshoot, \( M_{pt} \).
III.2 Analysis of Transducer Loading.

In this analysis, let us first derive the equations for \(i_1\), the current through the conducting GTCR, and the output voltage, \(E_L\). The equation for \(E_L\) along with data on input power would then provide the necessary information regarding amplifier performance, and could also be reflected to the primary so that we can insure that \(2E_L\) (primary) does not exceed the rated GTCR voltage. The resulting equation for \(i_1\) would then tell us whether or not we exceed rated current and also indicate when the limits of pulse gate drive would be exceeded.

To obtain the desired solutions for \(i_1\) and \(E_L\) we substitute the load circuit into the equivalent circuit developed in Chapter Two. The resulting circuit which we can attack analytically is shown in Figure III-2.

![Fig. III-2](image)
Solutions for $i_1$, the current through the conducting GTCR, and $E_L$ the output voltage can be written directly in Laplace Transforms.

$$i_1(s) = I_1'(s) + I_c'(s)$$

where

$$I_1'(s) = \frac{E}{N^2} \frac{(R_c C_s + 1)}{s (R_c C_L L_s^2 + L_L S + R_L)}$$

and

$$I_c'(s) = \frac{E}{S} \frac{2 C_c S}{R_c C_c S + 1}$$

and

$$E_L(s) = \frac{E R_l}{N} \frac{1}{s (R_c C_L L_s^2 + L_L S + R_L)}$$

The transient behavior of $i_1$ and $E_L$ is of considerable importance in devising protective schemes for the circuit. A readily apparent problem is that of overshoots of both current and applied voltage which could destroy the GTCR's, or at least change their characteristics, if rated surge values are approached or exceeded. Another transient aspect that must be considered however, is the minimum value of current, $i_1$, attained during undershoot. Since pulse type triggering of about 10 μ-sec duration will probably be employed, so that maximum current can be controlled, the current through the device must never be allowed to drop below the rated holding current. Should this occur the device will be switched to the high resistance portion of its operating curve, and power to the load will be interrupted. Interruptions of this sort are harmful if they also bring about transformer saturation on the following half cycle. Transformer saturation is very harmful for this circuit since in the on condition the primary circuit contains virtually no impedance,
and large currents will flow in the primary until protective devices operate.

Now that expressions for both \( i_1 \) and \( E_L \) are available, perhaps the best and quickest means of observing the transients would be to simulate the current and output voltage transfer functions on the analog computer. We could then observe the response to a step input of \( E \) volts with \( R_L \) fixed and the parameters \( L_L \) and \( C \) being varied.

To simplify the analog solution for \( i_1 \), rearrange the equation so that:

\[
I_i(s) = \frac{E}{R_L N^2 s (R_L C L L s^2 + L_L s + R_L)} + \frac{E R_L C s}{R_L N^2 s (R_L C L L s^2 + L_L s + R_L)} + \frac{E}{s} \left( \frac{2 C_C s}{R_C C_C s + 1} \right)
\]

let,

\[
I_i(s) = I_i'(s) + I_i''(s) + I_c(s)
\]

\[
I_i'(s) = \frac{E}{N^2 R_L} \frac{R_L}{s (R_L C L L s^2 + L_L s + R_L)}
\]

and

\[
I_i''(s) = \frac{E R_L C s}{N^2 R_L} \frac{R_L}{s (R_L C L L s^2 + L_L s + R_L)} = R_L C s I_i'(s)
\]

\[
I_c(s) = \frac{E}{s} \left( \frac{2 C_C s}{R_C C_C s + 1} \right)
\]

The analog circuit for the solution of \( i_1 \) is shown in Figure III-3.

(See Appendix II for the details of scaling)

Next write the equation for output voltage:

\[
E_L(s) = \frac{E}{N} \frac{R_L}{s (R_L C L L s^2 + L_L s + R_L)}
\]

which in transfer function form is

\[
\frac{E_L(s)}{E/N} = \frac{R_L}{R_L C L L s^2 + L_L s + R_L}
\]

For analog simulation consider then that

\[
\frac{R_L}{R_L C L L s^2 + L_L s + R_L} = \frac{F_0}{1 + F_0}
\]

40
Fig. III-3
where

\[ F_0 = \frac{R_L}{s(L_C s + 1)} \]

which becomes the open loop transfer function in the feedback analog circuit shown in Figure III-4.
III.3 Discussion of Analytical Results.

Figures III-5 through III-11 show the analytical results for $R_L$ and $L_L$ fixed and $C$ varying. We note that the range of parameters used covers the range of $\xi = .95$ to $\xi = .302$. Both current and voltage wave shapes followed the expected pattern, being damped heavily near $\xi = .95$ and growing oscillatory as $C$ was increased. At $\xi$'s near 0.3 we can see that the system has grown quite oscillatory, and that our voltage overshoot is now greater than 30%, and our current undershoot is very pronounced. Hence were our parameters to vary in this manner, we could safely predict that for this range the current $i_1$ remains above 50 milliamperes, the approximate holding current, and that the overshoot of output voltage will not exceed 36%.

The parameters below and scaling factors apply to Figures III-5 through III-11.

\[ R_L = 1440 \text{ ohms} \]
\[ L_L = 0.016 \text{ henries} \]

for current curves:
\[ \alpha_t = 9 \times 10^4 \]
\[ \alpha i_1 = 0.25 \]

for voltage curves
\[ \alpha_t = 54 \times 10^4 \]
\[ \alpha_{E_L} = 6 \]
\[ C = 0.0021 \mu F \quad \zeta = 0.95 \]

**Fig. III-5**
C = 0.0042 \mu F, \quad \xi = 0.678

**Fig. III-6**
$C = 0.00612 \mu F \quad \zeta = 0.562$

**Figure III-7**

[Graph showing a time vs. position relationship with annotations and grid lines for measurement.]
$C = 0.0082 \mu F \quad \zeta = 0.485$
$C = 0.011 \mu F \quad \xi = 0.418$

Fig. III-9
$C = 0.016 \mu F \quad \zeta = 0.347$

Fig. III-10
$C = 0.0212 \mu F \quad \xi = 0.302$
Figures III-12 through III-16 show what happens to the response when inductance is added. Additional inductance acts to dampen out the oscillations, however, there are limits to the amount of damping to be added, as is indicated by the slight lag in evidence in the current $i_1$ shown in Figure III-16. As more inductance is added we will be once more in danger of dropping below the rated holding current for the GICR with possible transformer saturation on the next half cycle.

The fixed parameters and scaling factors for Figures III-12 through III-16 are:

\[ R_L = 1440 \ \text{ohms} \]
\[ C = 0.00612 \ \text{microfarads} \]
\[ \alpha_i = 0.025 \]
\[ \alpha E_L = 6 \]
\[ L = \frac{9}{8} L_1 \quad \alpha_t = 48 \times 10^4 \]
\[ L = \frac{5}{4} L_2 \quad \alpha_\text{c} = 43.2 \times 10^4 \]
\[ L = \frac{3}{2} L_2 \quad = 36 \times 10^4 \]

\[ t \rightarrow \quad 5 \text{mm/sec} \]

\[ t \rightarrow \quad 1 \text{mm/sec} \]

Fig. XXX-14
\[ L = 2 L_1 \quad \alpha_t = 27 \times 10^4 \]

Fig. III-15
\[ L = 6 L_1 \quad \alpha_t' = 9 \times 10^4 \]

Fig. X1-16
III.4 Experimental Results.

We can visually compare the predicted results with the observed values shown in Figures III-19 through III-25 and note about 1 to 6% deviation. Table A-1 portrays the tabulated experimental results and also shows the predicted values of overshoot based on the curve of Figure III-17.

<table>
<thead>
<tr>
<th>C</th>
<th>M_cal</th>
<th>M_obs</th>
<th>% dev</th>
<th>Power gain</th>
<th>Efficiency</th>
</tr>
</thead>
<tbody>
<tr>
<td>.0021</td>
<td>.95</td>
<td>1.008</td>
<td>1.064</td>
<td>5.27</td>
<td>1028</td>
</tr>
<tr>
<td>.0042</td>
<td>.678</td>
<td>1.054</td>
<td>1.110</td>
<td>5.05</td>
<td>89%</td>
</tr>
<tr>
<td>.00612</td>
<td>.562</td>
<td>1.120</td>
<td>1.136</td>
<td>1.41</td>
<td>89%</td>
</tr>
<tr>
<td>.0082</td>
<td>.485</td>
<td>1.170</td>
<td>1.160</td>
<td>0.86</td>
<td>88%</td>
</tr>
<tr>
<td>.0110</td>
<td>.418</td>
<td>1.230</td>
<td>1.195</td>
<td>2.93</td>
<td>87.7%</td>
</tr>
<tr>
<td>.0160</td>
<td>.347</td>
<td>1.310</td>
<td>1.234</td>
<td>6.15</td>
<td>86.5%</td>
</tr>
<tr>
<td>.0212</td>
<td>.302</td>
<td>1.360</td>
<td>1.272</td>
<td>6.90</td>
<td>85.7%</td>
</tr>
</tbody>
</table>
Fig. III-17
Fig. III-19

Output Voltage $E_L$ vs Time

$C = 0.00212 \ \mu\text{farads}$
Fig. III-20
Output Voltage \( E_L \) vs Time

\[ C = 0.0042 \, \mu \text{farads} \]
Fig. III-21
Output Voltage $E_L$ vs Time

$C = 0.0061$ $\mu$farads
Output Voltage $E_L$ vs Time

$C = 0.0082 \mu \text{farads}$
Output Voltage $E_L$ vs Time

$C = 0.011 \ \mu \text{farads}$
Fig. III-24

Output Voltage $E_L$ vs Time

$C = \, .016$ $\mu$farads
Fig. III-25

Output Voltage $E_L$ vs Time

$C = 0.021 \ \mu\text{farads}$
III.5 Conclusions Based on Experimental Results.

The basic reason for the observed deviation from predicted results is that the desired load could not be simulated with our laboratory components. The actual transfer functions were of third order rather than second order due to the inductance associated with the wire wound resistor used. Our actual load was really,

$$Z_L(s) = sL_e + \frac{R_e + sL_R}{s^2L_R C + R_L C s + 1}$$

$$= L_L \left[ \frac{s(s^2 + sR_L L_e + 1/RL_C) + s/L_e C + R_L /L_RC}{s^2 + RL_L s/L_R + 1/L_RC} \right]$$

where $L_R$ = the inductance due to the resistor.

The transfer function for output voltage was really:

$$\frac{E_i(s)}{E/N} = \frac{R_L + sL_R}{sL_L (s^2L_R C + R_L C s + 1) + sL_R + R_L}$$

The system characteristic equation is then

$$s^3 + \frac{R_L s^2}{L_R} + \left( \frac{1}{L_R C} + \frac{1}{L_L C} \right) s + \frac{R_L}{L_R L_R L_L C}$$

Letting

$$X(s) = s \left( \frac{1}{L_R C} + \frac{1}{L_L C} \right) + \frac{R_L}{L_R L_L C}$$

and

$$Y(s) = s^3 + \frac{R_L}{L_R} s^2$$

we can examine the effects of varying $C$ by plotting $x(s)/y(s)$ on a root locus plot and observing the movement of the roots.

$$\frac{X(s)}{Y(s)} = \frac{1}{L_R C} \left( \frac{L_R + L_L}{R_L} \right) s + 1 \quad \frac{s^2 \left( \frac{L_R}{R_L} s + 1 \right)}{s^2 \left( \frac{L_R}{R_L} s + 1 \right)}$$
A sketch of the Root Locus plot for the actual experimental system is shown below.

For the range of capacitance used in the laboratory, performance was approximately in the range shown by the dotted lines on the sketch.
In addition to the data tabulated, a dual beam oscilloscope was used to verify frequency correspondence. It was found that the leading edge of each pulse could be aligned with the zero crossings of the output voltage wave shape, hence frequency was preserved.

We can see now by examining both the analytical and observed results that for the range $\bar{F} = .95$ to $\bar{F} = .302$ the frequency has been preserved, the amplitude of the output voltage has deviated from the average half cycle value by at most 36%, and that efficiencies on the order of 85% at power gains of about 1000 are possible.

We could now predict that for this GTCR, rated at 400 volts and 2 amperes, we could, with a proper output transformer, operate safely at 200 watts output power with a power gain of 1000. The output transformer must be designed so that the reflected resistance allows rated current at the desired supply voltage, without saturating. Also, a resistor should be inserted during at least the first half cycle in series with the power supply to prevent the transformer from saturating due to residual flux of the same sense as the flux due to the in-rushing current.
BIBLIOGRAPHY


APPENDIX I

TRIGGERING CIRCUIT

The triggering circuit used in the experimental section is shown below:

The Shockley diode is a four layer, Silicon, two terminal switch. The Voltage-Current characteristic curve for this p-n-p-n device shows two stable states, a high impedance state, Region I, and a low impedance state Region III. To turn the device on the voltage across the terminals must exceed the switching voltage, $V_s$. Turn-off is accomplished by reducing the current through the device below the rated holding current. The V-I curve and other diode characteristics are shown in Figure A-1.

For the triggering circuit, a Shockley diode with a switching voltage of 30 volts was used with the following effects on triggering operations:

1. Pulse Interval $T$
This is a diagram of the construction of the Shockley 4-layer diode. Produced from single-crystal silicon, the four layers are obtained by the controlled diffusion of suitable impurities.

The symbol for the Shockley 4-layer diode is a modified “4”; the slant line of the “4” indicates the forward direction of current passing through the device when in the “on” state.

**Terms and Symbols**

- \( V_s \) Switching Voltage
- \( I_s \) Switching Current
- \( I_h \) Holding Current (or Sustaining Current)
- \( V_h \) Holding Voltage
- \( R_{on} \) “On” resistance (the slope of the V-I curve measured at currents \( > I_h \))
- \( I_{lk} \) Leakage Current
- \( V_{rb} \) Reverse Breakover (Avalanche) Voltage

**Other Characteristics For All Standard Type D Units**

<table>
<thead>
<tr>
<th>Voltage</th>
<th>Current</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>( V_s )</td>
<td>( I_s )</td>
<td>Switching Current: (&lt;125 \mu s)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Holding Voltage: 0.5 to 1.2 volts</td>
</tr>
<tr>
<td>( I_h )</td>
<td></td>
<td>Current Carrying Capacity: 50 mA steady dc. Maximum peak current rating 2 amperes—dependent on duty factor, repetition rate, pulse duration and ambient temperature.</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Turn-On Time: 0.1 ( \mu s ) (circuit will determine exact switching time)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Turn-Off Time: 0.2 ( \mu s ) (circuit will determine exact switching time)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Leakage Current: (&lt;15 \mu s ) (measured at 0.75 ( V_s ))</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Dynamic Resistance On (( R_{on} )): (&lt;2) ohms at ( I_h ) + 25 mA and (&lt;0.3) ohm at 2 amperes</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Capacitance: (&lt;100) pf (Exact value depends on ( V_s ) and applied voltage)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Ambient Temperature Operating Range: (-40^\circ ) to ( 65^\circ )C</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Reverse Breakover (Avalanche) Voltage (( V_{rb} )): ( &gt;60% ) of nominal switching voltage (( V_s )). Voltages applied in the reverse direction in excess of ( V_{rb} ) may cause damage to the device.</td>
</tr>
</tbody>
</table>

**URCIAL Series**

**4-LAYER DIODE FOR 2 AMPERE PULSE CURRENTS**

<table>
<thead>
<tr>
<th>Voltage</th>
<th>Current</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>( V_s )</td>
<td>( I_s )</td>
<td>Switching Current: (&lt;125 \mu s)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Holding Voltage: 0.5 to 1.2 volts</td>
</tr>
<tr>
<td>( I_h )</td>
<td></td>
<td>Current Carrying Capacity: 50 mA steady dc. Maximum peak current rating 2 amperes—dependent on duty factor, repetition rate, pulse duration and ambient temperature.</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Turn-On Time: 0.1 ( \mu s ) (circuit will determine exact switching time)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Turn-Off Time: 0.2 ( \mu s ) (circuit will determine exact switching time)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Leakage Current: (&lt;15 \mu s ) (measured at 0.75 ( V_s ))</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Dynamic Resistance On (( R_{on} )): (&lt;2) ohms at ( I_h ) + 25 mA and (&lt;0.3) ohm at 2 amperes</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Capacitance: (&lt;100) pf (Exact value depends on ( V_s ) and applied voltage)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Ambient Temperature Operating Range: (-40^\circ ) to ( 65^\circ )C</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Reverse Breakover (Avalanche) Voltage (( V_{rb} )): ( &gt;60% ) of nominal switching voltage (( V_s )). Voltages applied in the reverse direction in excess of ( V_{rb} ) may cause damage to the device.</td>
</tr>
</tbody>
</table>

**Fig. A-1**

**RATINGS ABOVE APPLY AT 25°C**

73
We can calculate $T$ by determining the time required to charge the capacitor to 30 volts. The expression for the voltage across the capacitor is

\[ V_c = E_s \left( 1 - e^{-\frac{t}{RC}} \right) \]

for $E_s = 100$ volts, $C = .1 \mu f$ and at time $t = T$,

$V_c = 30$.

hence

\[ \frac{V_c}{E_s} - 1 = - e^{\frac{-t}{RC}} \]

\[ . \cdot t_i = RC \ln \left( \frac{V_c}{E_s} - 1 \right) = .1 R \ln \left( \frac{100}{70} \right) = .0358 R \mu sec \]

2. Pulse height $I_p$

\[ I_p = \frac{V_s}{R_c} = 30/20 = 1.5 \text{ amps} \]

3. Pulse width $t_w$

The pulse width is the time required for the current to decay below the rated holding current of approximately 45 mA.

Current decay can be expressed by,

\[ I = I_p e^{-t/RcC} \]

which for the parameters used is

\[ .045 = 1.5 e^{\frac{-t_w}{2.0 \times 10^6}} \]

\[ t_w = 2.0 \times 10^{-6} \ln \left( \frac{.045}{1.5} \right) = 7.6 \mu seconds \]
APPENDIX II

ANALOG SOLUTION FOR AMPLIFIER CURRENT

The expression for amplifier current is,

\[ I_i(s) = \frac{E}{N^2 R_L} \frac{R_L}{s(R_L C_L s^2 + L_L s + R_L)} + \frac{E R_C s R_u}{N^2 R_L s(R_L C_L s^2 + L_L s + R_L)} + \frac{2 E C s}{s (R_C s + 1)} \]

using the variables as shown on the analog circuit diagram Figure A-2, the scaling equations become:

\[ \frac{E_i}{E} = \frac{\alpha_E}{\alpha_{E*}} \frac{E}{R_u N^2} \]

\[ \frac{E}{E_i} = \frac{\alpha_{E*}}{\alpha_E} E_i - \frac{\alpha_{E*} I_i}{\alpha_E} \]

\[ \frac{I_i}{I_{i*}} = \frac{\alpha_{E*}}{\alpha_E} \frac{R_L}{L_L} \frac{E_i}{(RC_s + 1)} \]

Let \( F = F(s) \),

\[ \alpha_E = 1 \quad \alpha_{E*} = \frac{1}{N^2 R_L} \]

\[ R_i = R_{f1} = 1 \text{ Meg} \cdot \text{ohm} \]

\[ a_1 = 1 \]

\[ \alpha_E = \alpha_{E*} = \alpha_{E*} \]

\[ R_z = R_3 = R_{f3} = 1 \text{ Meg} \cdot \text{ohm} \]

\[ a_2 = a_3 = 1 \]

\[ \frac{\alpha_{E*}}{\alpha_E} = \frac{1}{N^2 L_L} \quad \alpha_t = \frac{R_u}{L_L} = 9 \times 10^4 \]

\[ L_L = .016 \text{ henries} \]

\[ R_L = 1440 \text{ ohm} \]

\[ \frac{a_4 R_{f4}}{a_6 R_u} = 1 \]

\[ \frac{C_{f4} R_{f4}}{a_6} = \frac{R_u^2 C}{L_L} = 129.6 \text{ C} \times 10^6 \]
In Tabular Form the \( \alpha \) for \( R_L \) and \( L_C \) fixed and \( C \) variable.

<table>
<thead>
<tr>
<th>( C \mu f )</th>
<th>( \alpha \beta )</th>
<th>( C_{f1} \mu f )</th>
<th>( R_{f1} ) M ( \Omega )</th>
<th>( R_1 ) M ( \Omega )</th>
<th>( \alpha_4 )</th>
</tr>
</thead>
<tbody>
<tr>
<td>.0021</td>
<td>.919</td>
<td>1</td>
<td>.25</td>
<td>.25</td>
<td>.919</td>
</tr>
<tr>
<td>.0042</td>
<td>.46</td>
<td>1</td>
<td>.25</td>
<td>.25</td>
<td>.46</td>
</tr>
<tr>
<td>.00612</td>
<td>.315</td>
<td>1</td>
<td>.25</td>
<td>.25</td>
<td>.315</td>
</tr>
<tr>
<td>.0082</td>
<td>.94</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.94</td>
</tr>
<tr>
<td>.011</td>
<td>.702</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.702</td>
</tr>
<tr>
<td>.016</td>
<td>.483</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.483</td>
</tr>
<tr>
<td>.0212</td>
<td>.364</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.364</td>
</tr>
</tbody>
</table>

\[
I_i' = \int \frac{\alpha_i \alpha_i'}{\alpha_i} \frac{dI_i}{dt}
\]

\[
I_i'' = \frac{\alpha_i}{\alpha_i} R C I_i'
\]

\[
E_0 = \frac{\alpha E_i}{\alpha E_0} \frac{E_i}{R_C C S + 1}
\]

\[
I_c = \frac{\alpha_i E_i}{\alpha_i} - \frac{2 R_L N^2}{\alpha_i} \frac{E_i}{\alpha_i} E_0
\]

\[
\alpha_5 = 1
\]

\[
\frac{a_5}{R_5 C_{f5}} = 1
\]

\[
R_5 = 1 \text{ M} \Omega
\]

\[
C_{f5} = 1 \mu f
\]

\[
\alpha_i = \frac{R C}{N^2 L_L}
\]

\[
\alpha_i = R_7 = 1 \text{ M} \Omega
\]

\[
\alpha E_0 = \frac{\alpha E_0}{N^2 R_L} = 1
\]

\[
\frac{a_8 R_{f8}}{a_9 R_8} = 1
\]

\[
\frac{C_{f8} R_{f8}}{a_9} = R_C C \alpha_c
\]

\[
C_{f8} = 1 \mu f
\]

\[
R_8 = R_{f8} = 0.25 \text{ M} \Omega
\]

\[
a_8 = a_9 = 0.617
\]

\[
I_c = \frac{\alpha_i E_i}{\alpha_i} - \frac{2 R_L N^2}{\alpha_i} \frac{E_i}{\alpha_i}
\]

\[
\alpha i_c = \alpha E_c = \alpha E_c
\]

\[
\frac{a_{10} R_{f10}}{R_{10}} = \frac{a_{11} R_{f10}}{R_{11}} = \frac{2 R_L N^2}{R_C}
\]

\[
R_{f10} = 1 \text{ M} \Omega
\]

\[
R_{10} = R_{11} = 0.25 \text{ M} \Omega
\]

\[
a_{10} = a_{11} = 0.667
\]
\[
\begin{align*}
I_i &= \frac{\alpha_i}{\alpha_i'} I_i' + \frac{\alpha_i''}{\alpha_i'} I_i'' + \frac{\alpha_i e}{\alpha_i'} I_c \\
\alpha_i &= \alpha_i' = \alpha_i'' = \frac{1}{N^3 R_i}
\end{align*}
\]

\[
R_{12} = R_{12} = R_{14} = 1 \text{ M } \Omega
\]

\[
a_{12} = a_{14} = 1
\]

\[
a_{13} = R_L C \alpha_t \left( \frac{R_{13}}{R_{12}} \right) = 129.6 \times 10^6 C \frac{R_{13}}{R_{12}}
\]

For \( R_{13} = 1 \text{ M } \Omega \)

<table>
<thead>
<tr>
<th>( C \mu F )</th>
<th>( a_{13} )</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.0021</td>
<td>0.0272</td>
</tr>
<tr>
<td>0.0042</td>
<td>0.0544</td>
</tr>
<tr>
<td>0.00812</td>
<td>0.0793</td>
</tr>
<tr>
<td>0.0082</td>
<td>0.0162</td>
</tr>
<tr>
<td>0.011</td>
<td>0.1425</td>
</tr>
<tr>
<td>0.016</td>
<td>0.207</td>
</tr>
<tr>
<td>0.0212</td>
<td>0.2745</td>
</tr>
</tbody>
</table>

Now keeping \( R_L = 1440 \text{ } \Omega \) and \( C \) fixed at 0.00612 \( \mu F \) vary \( L \) in steps as follows:

\[
L = \frac{9}{8} L_L, \frac{5}{4} L_L, \frac{3}{2} L_L, 2 L_L, 6 L_L
\]

The only modifications to the above occur due to change in \( \alpha_t = \frac{R_L}{L_L} \).

Hence affected pots are varied \( a_4 \) and \( a_6 \) increasing and \( a_{13} \) decreasing.
<table>
<thead>
<tr>
<th>( L )</th>
<th>( \alpha_4' )</th>
<th>( \alpha_6' )</th>
<th>( \alpha_{13}' )</th>
</tr>
</thead>
<tbody>
<tr>
<td>9/8 ( L_1 )</td>
<td>0.3545</td>
<td>0.3545</td>
<td>0.0705</td>
</tr>
<tr>
<td>5/1 ( L_1 )</td>
<td>0.394</td>
<td>0.394</td>
<td>0.0635</td>
</tr>
<tr>
<td>3/2 ( L_1 )</td>
<td>0.473</td>
<td>0.473</td>
<td>0.053</td>
</tr>
<tr>
<td>2 ( L_1 )</td>
<td>0.709</td>
<td>0.709</td>
<td>0.0353</td>
</tr>
<tr>
<td>6 ( L_c )</td>
<td>0.756</td>
<td>0.756</td>
<td>0.0112</td>
</tr>
</tbody>
</table>

with \( R_4 = R_4 = 0.1 \text{ M } \Omega \).
Next write the equation for output voltage
\[ E_L = \frac{E}{N} \frac{R_L}{s(R_lC_lS^2 + L_lS + R_l)} \]

which in transfer function form is:
\[ \frac{E_L}{E/N} = \frac{R_L}{R_lC_lS^2 + L_lS + R_l} = \frac{F_o}{1 + F_o} \]

For analog simulation consider then that
\[ \frac{R_L}{R_lC_lS^2 + L_lS + R_l} = \frac{R_L/L_l}{s(R_lC_lS+1)} \]

the open loop transfer function in the feedback analog circuit shown in Fig. A-3. The analog expressions are then:

\[ \frac{E}{N} = \frac{\alpha_E}{\alpha_{E_l}} 100 \quad \alpha_1 = .3 \quad R_1 = R_{f1} = 1 \text{ M} \Omega \]

\[ E_T = \frac{\alpha_E}{\alpha_{E_l}} \frac{E}{N} - \frac{\alpha_{E_l}}{\alpha_E} \frac{E_L}{E} \quad \alpha_E = \alpha_E = \alpha_{E_l} = 6 \]
\[ a_2 = a_3 = 1 \quad R_2 = R_3 = R_{f2} = 1 \text{ M} \Omega \]

\[ \frac{E_L}{E} = \frac{\alpha_{E_l}}{\alpha_E} \frac{E}{R_L/L_l} \frac{R_{f4}C_{f4}}{R_lC_s+1} \]
\[ \alpha_t = 6 \frac{R_L}{L_l} = 54 \times 10^4 \]
\[ \frac{R_{f4}C_{f4}}{a_5} = R_lC \alpha_t \]
\[ a_5 = R_{f4}C_{f4} \quad a_4 = a_5 \frac{R_4}{R_{f4}} \]
First let $R = 1440 \Omega$ and $L_L = .016 \text{ h}$ remain fixed and vary.

C. The pot settings for $A_4$ and $A_5$ may be tabulated as shown below:

<table>
<thead>
<tr>
<th>$C_4 \mu F$</th>
<th>$C_4 \mu F$</th>
<th>$R_{f4} \text{ M } \Omega$</th>
<th>$R_3$</th>
<th>$A_5$</th>
<th>$A_4$</th>
</tr>
</thead>
<tbody>
<tr>
<td>.0021</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.603</td>
<td>.603</td>
</tr>
<tr>
<td>.0042</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.3015</td>
<td>.3015</td>
</tr>
<tr>
<td>.00612</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.210</td>
<td>.210</td>
</tr>
<tr>
<td>.0082</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.157</td>
<td>.157</td>
</tr>
<tr>
<td>.011</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.117</td>
<td>.117</td>
</tr>
<tr>
<td>.016</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.0804</td>
<td>.0804</td>
</tr>
<tr>
<td>.0212</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>.0606</td>
<td>.0606</td>
</tr>
</tbody>
</table>

$$E_L = \int \frac{\alpha E_L}{\alpha_{E_L} \alpha_t} \frac{\alpha_6}{R_6 C_{f6}} = \frac{1}{6}$$

$$R_6 = 1 \text{ M } \Omega$$
$$C_{f6} = 1 \mu F$$
$$A_6 = .167$$

Now keep $R = 1440 \Omega$, $C = .00612 \mu F$ and vary $L_1$. The required changes will be in pot settings $A_4$ and $A_5$:

<table>
<thead>
<tr>
<th>$L$</th>
<th>$A_5$</th>
<th>$A_4$</th>
<th>$\alpha_t$</th>
</tr>
</thead>
<tbody>
<tr>
<td>9/8 $L_1$</td>
<td>.236</td>
<td>.236</td>
<td>48 X $10^4$</td>
</tr>
<tr>
<td>5/4 $L_1$</td>
<td>.2625</td>
<td>.2625</td>
<td>43.2 X $10^4$</td>
</tr>
<tr>
<td>3/2 $L_1$</td>
<td>.315</td>
<td>.315</td>
<td>36 X $10^4$</td>
</tr>
<tr>
<td>2 $L_1$</td>
<td>.42</td>
<td>.42</td>
<td>27 X $10^4$</td>
</tr>
<tr>
<td>6 $L_1$</td>
<td>.315</td>
<td>.315</td>
<td>9 X $10^4$  (change $R_{f4} = R_4 = .25 \text{ M } \Omega$)</td>
</tr>
</tbody>
</table>